Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10695259	TAN, WAI-TIAN
Examiner	Art Unit
Nguyen-Ba, Hoang-Vu A	2421

SEARCHED				
Class	Subclass	Date	Examiner	
725	149	8/23/07	HAN	

SEARCH NOTES			
Search Notes	Date	Examiner	
East Text Search USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	8/23/07	HAN	
East Text Search USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB	10/22/08	HAN	

INTERFERENCE SEARCH			
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